FAIRCHILD SEMICONDUCTOR®

December 2010

BSS138W

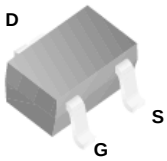
N-Channel Logic Level Enhancement Mode Field Effect Transistor

General Description

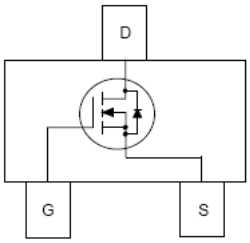
These N-Channel enhancement mode field effect transistor. These products have been designed to minimize on-state resistance while provide rugged, reliable, and fast switching performance.These products are particularly suited for low voltage, low current applications such as small servo motor control, power MOSFET gate drivers, and other switching applications.

Features

- $R_{DS(ON)}$ = 3.5Ω @ V_{GS} = 10V, I_D = 0.22A
  $R_{DS(ON)}$ = 6.0Ω @ V_{GS} = 4.5V, I_D = 0.22A
- High density cell design for extremely low $R_{DS(ON)}$
- Rugged and Reliable
- Compact industry standard SOT-323 surface mount package



SOT−323
Marking : 138



Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	Value	Units
V_{DSS}	Drain-Source Voltage	50	V
V_{GSS}	Gate-Source Voltage	±20	V
I_D	Drain Current - Continuous (Note1) - Pulsed	0.21 0.84	A A
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C
T_L	Maximum Lead Temperature for Soldering Purposes, 1/16” from Case for 10 Seconds	300	°C

Thermal Characteristics

Symbol	Parameter	Value	Units
P_D	Maximum Power Dissipation (Note1) Derate Above 25°C	340 2.72	mW mW/°C
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note1)	367	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
138	BSS138W	7”	8mm	3000 units

Electrical Characteristics T_A = 25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0V, I_D = 250μA	50			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250μA, Referenced to 25°C		71		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 50V, V_{GS} = 0V V_{DS} = 50V, V_{GS} = 0V, T_J = 125°C V_{DS} = 30V, V_{GS} = 0V			0.5 5 100	μA μA nA
I_{GSS}	Gate-Body Leakage	V_{GS} = ±20V, V_{DS} = 0V			±100	nA
On Characteristics (Note2)						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 1mA	0.8	1.3	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 1mA, Referenced to 25°C		-3.9		mV/°C
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS} = 10V, I_D = 0.22A V_{GS} = 4.5V, I_D = 0.22A V_{GS} = 10V, I_D = 0.22A, T_J=125°C		1.17 1.36 2.16	3.5 6.0 5.8	Ω Ω Ω
$I_{D(ON)}$	On-State Drain Current	V_{GS} = 10V, V_{DS} = 5V	0.2			A
g_{FS}	Forward Transconductance	V_{DS} = 10V, I_D = 0.22A	0.12			S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 25V, V_{GS} = 0V, f = 1.0MHz		38		pF
C_{oss}	Output Capacitance			5.9		pF
C_{rss}	Reverse Transfer Capacitance			3.5		pF
R_G	Gate Resistance	V_{GS} = 15mV, f = 1.0MHz		11		Ω
Switching Characteristics (Note2)						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = 30V, I_D = 0.29A, V_{GS} = 10V, R_{GEN} = 6Ω		2.3	5	ns
t_r	Turn-On Rise Time			1.9	18	ns
$t_{d(off)}$	Turn-Off Delay Time			6.7	36	ns
t_f	Turn-Off Fall Time			6.5	14	ns
Q_g	Total Gate Change	V_{DS} = 25V, I_D = 0.22A, V_{GS} = 10V		1.1		nC
Q_{gs}	Gate-Source Change			0.12		nC
Q_{gd}	Gate-Drain Change			0.22		nC
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain–Source Diode Forward Current				0.22	A
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0V, I_S = 0.44A (Note2)			1.4	V

Notes:

1. 367°C/W when mounted on a minimum pad.

2. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2.0%

Typical Performance Characteristics

Figure 1. On-Region Characteristics.

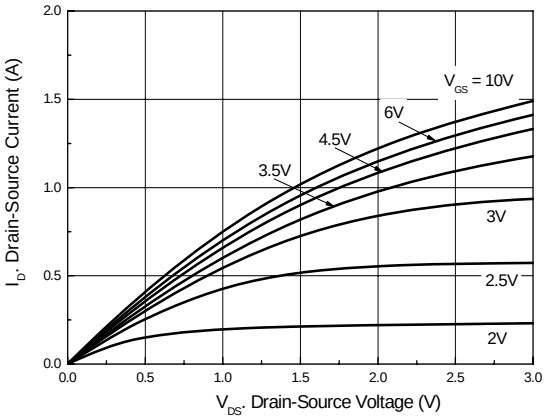


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

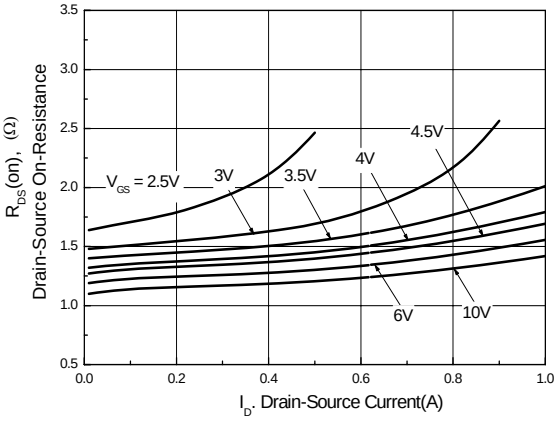


Figure 3. On-Resistance Variation with Temperature.

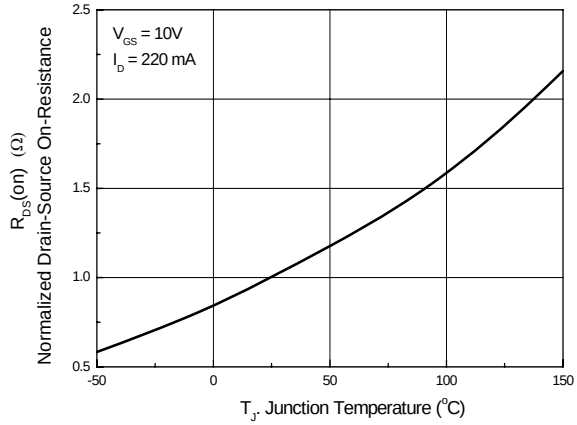


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

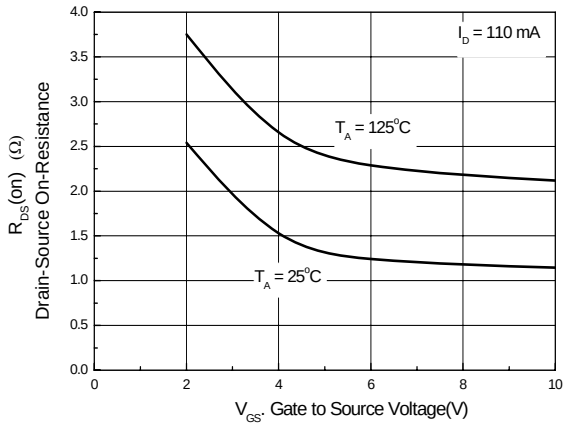


Figure 5. Drain-Source On Voltage with Temperature.

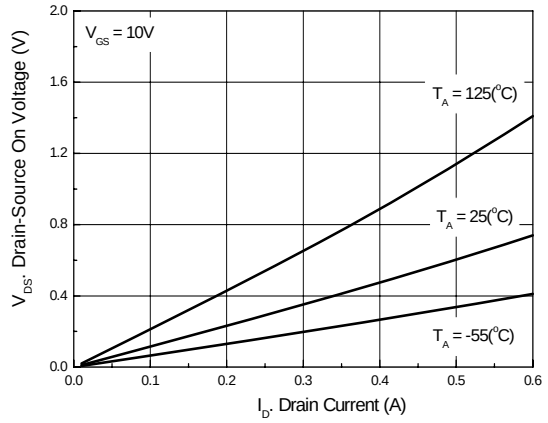
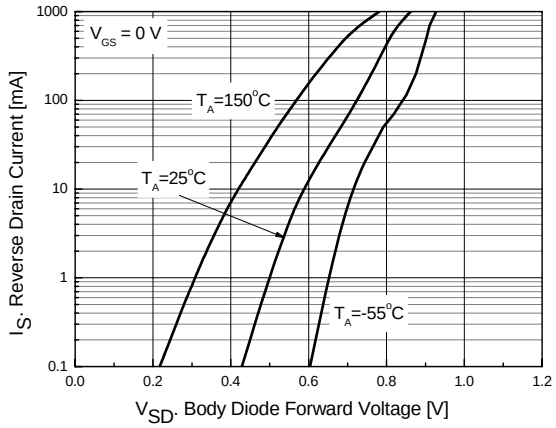


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.



Typical Performance Characteristics (Continued)

Figure 7. Gate Charge Characteristics.

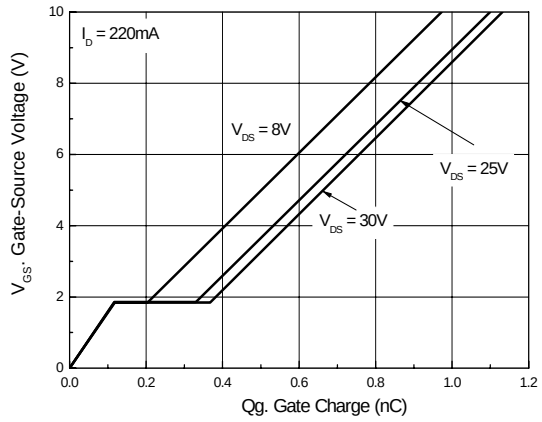


Figure 8. Capacitance Characteristics.

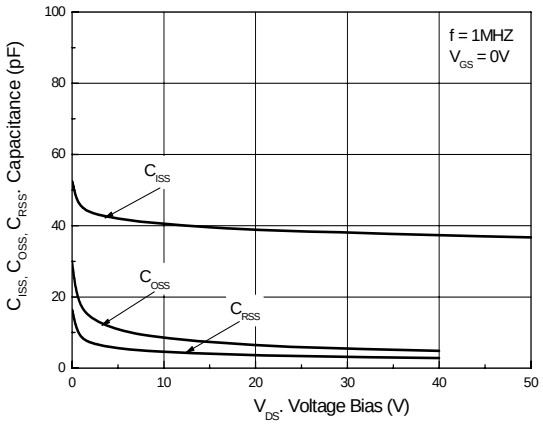


Figure 9. Maximum Safe Operating Area.

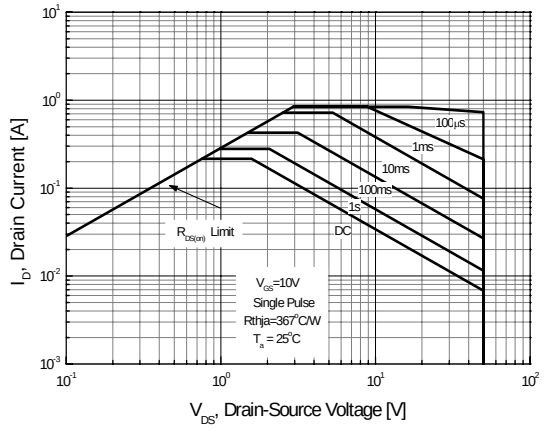


Figure 10. Single Pulse Maximum Power Dissipation.

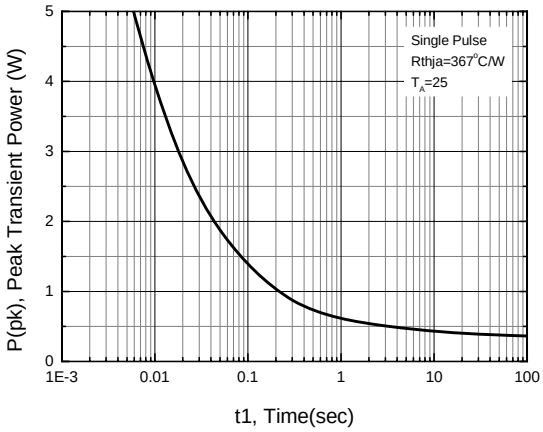
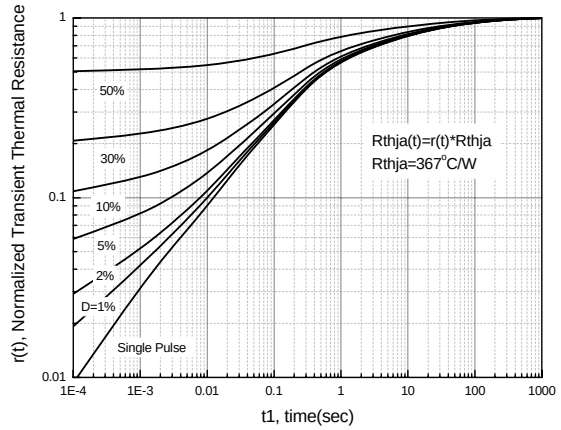
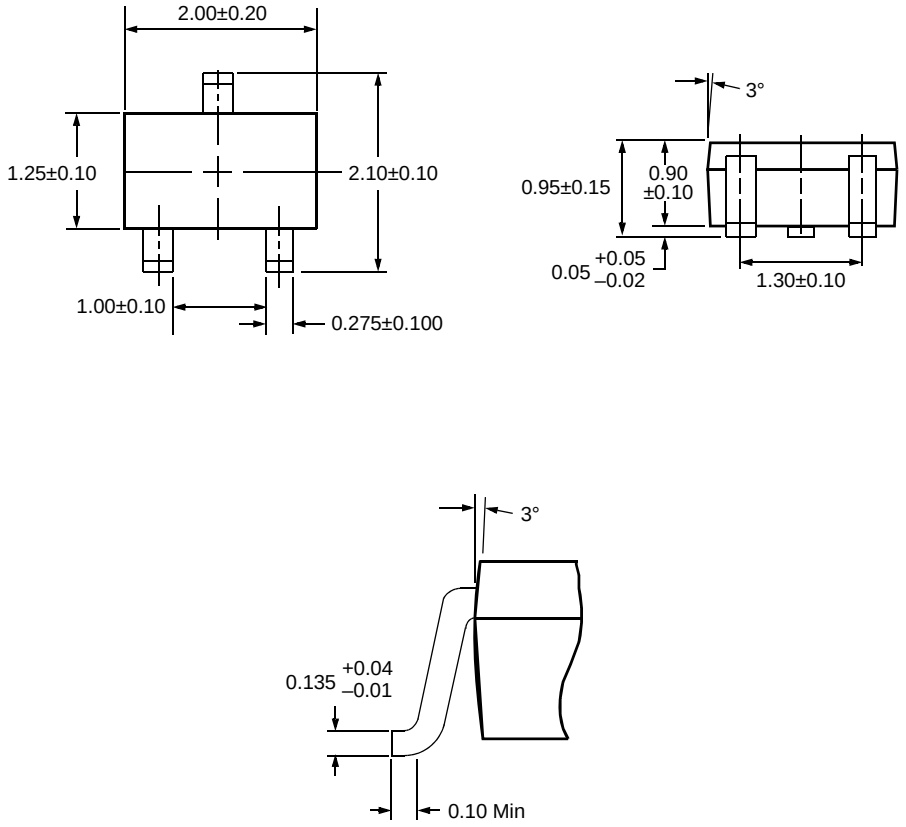


Figure 11. Transient Thermal Response Curve.



Physical Dimensions

SOT-323



Dimensions in Millimeters

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